







U.S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date (if appropriate)
	AA						
	AB						
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	AH						
	AI						
	AJ						

FOREIGN PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	TRANSLATION	
							Yes	No
	AK	4-358031	12/1992	Japan			Yes	
	AL	57-135776	08/1982	Japan			Yes	
	AM	3-177384	08/1991	Japan			Yes	
	AN							
	AO							
	AP							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)									
	AQ	Japanese Office Action with English Translation							
	AR								
	AS								
EXAMINER <i>M. J. ...</i>			DATE CONSIDERED <i>1/04</i>						
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